

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10522231	MAYER ET AL.
	Examiner	Art Unit
	Ahshik Kim	2876

SEARCHED

Class	Subclass	Date	Examiner
235	454	7/25/07	AK
	491	7/25/07	AK
	462.41	7/25/07	AK
	462.42	7/25/07	AK
	457	7/25/07	AK
356	71	7/25/07	AK
	73.1	7/25/07	AK

SEARCH NOTES

Search Notes	Date	Examiner
Updated Search	1/30/08	ak
Updated Search	9/12/2008	ak

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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